

Notice of References Cited	Application/Control No. 09/303,062	Applicant(s)/Patent Under Reexamination MENDHEKAR ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,351,771	02-2002	Craddock et al.	709/227
	B	US-6,496,693	12-2002	Tran, Trung M.	455/426
	C	US-6,216,157	04-2001	Vishwanath et al.	709/208
	D	US-6,108,696	08-2000	Mendhekar et al.	709/217
	E	US-			
	F	US-			
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